

Notice of References Cited		Application/Control No.	Applicant(s)/Patent Under Reexamination 10/661,481 NISHITANI ET AL.	
		Examiner Eleni A. Shiferaw	Art Unit 2136	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-5,233,434 A	08-1993	Furuki et al.	386/33
*	B	US-5,930,369 A	07-1999	Cox et al.	380/54
*	C	US-6,021,196 A	02-2000	Sandford et al.	713/176
*	D	US-6,049,627 A	04-2000	Becker et al.	382/181
*	E	US-2001/0026616 A1	10-2001	Tanaka, Nobuyuki	380/202
*	F	US-6,334,187 B1	12-2001	Kadono, Shinya	713/176
*	G	US-6,341,350 B1	01-2002	Miyahara et al.	713/176
*	H	US-2002/0129253 A1	09-2002	Langelaar, Gerrit Cornelis	713/176
*	I	US-6,512,836 B1	01-2003	Xie et al.	382/100
*	J	US-2004/0003253 A1	01-2004	Ogino et al.	713/176
*	K	US-6,725,372 B1	04-2004	Lewis et al.	713/176
*	L	US-6,785,814 B1	08-2004	Usami et al.	713/176
*	M	US-7,159,117 B2	01-2007	Tanaka, Nobuyuki	713/176

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.